imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

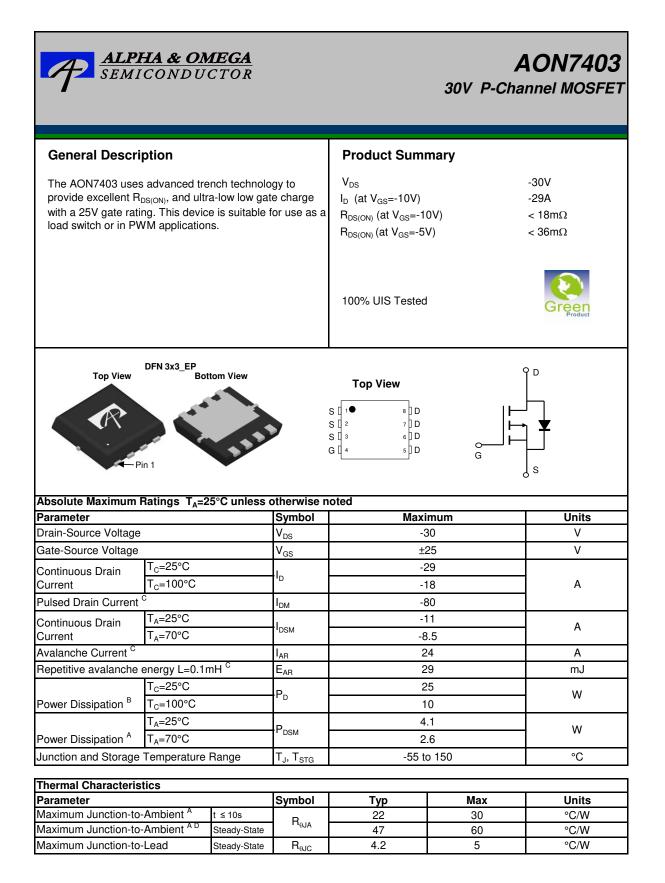
We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





Electrical Characteristics (TJ=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	I_{D} =-250 μ A, V_{GS} =0V	-30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V			-1	μA
		T _J =5	55°C		-5	
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 25V$			100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=-250\mu A$	-1.7	-2.2	-3	V
I _{D(ON)}	On state drain current	V_{GS} =-10V, V_{DS} =-5V	-80			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =-10V, I_{D} =-8A		14	18	mΩ
		T _J =12	25°C	20	25	
		V_{GS} =-5V, I_{D} =-5A		26	36	mΩ
9 _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-8A		20		S
V _{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V		-0.7	-1	V
I _S	Maximum Body-Diode Continuous Curr	urrent			-22	Α
DYNAMIC	C PARAMETERS					
C _{iss}	Input Capacitance			1130	1400	pF
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =-15V, f=1MHz		240		pF
C _{rss}	Reverse Transfer Capacitance]		155		pF
R _g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		5.8	8	Ω
SWITCHI	NG PARAMETERS					
Q _g (10V)	Total Gate Charge			18	24	nC
Q _{gs}	Gate Source Charge	V_{GS} =-10V, V_{DS} =-15V, I_{D} =-8A	۱	5.5		nC
Q _{gd}	Gate Drain Charge			3.3		nC
t _{D(on)}	Turn-On DelayTime			8.7		ns
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-15V, R_{L} =1.8	8Ω,	8.5		ns
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		18		ns
t _f	Turn-Off Fall Time] [7		ns
t _{rr}	Body Diode Reverse Recovery Time	I_F =-8A, dI/dt=500A/µs		12	16	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-8A, dI/dt=500A/μs		26		nC

A. The value of R_{0.1A} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R _{aJA} t \leq 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

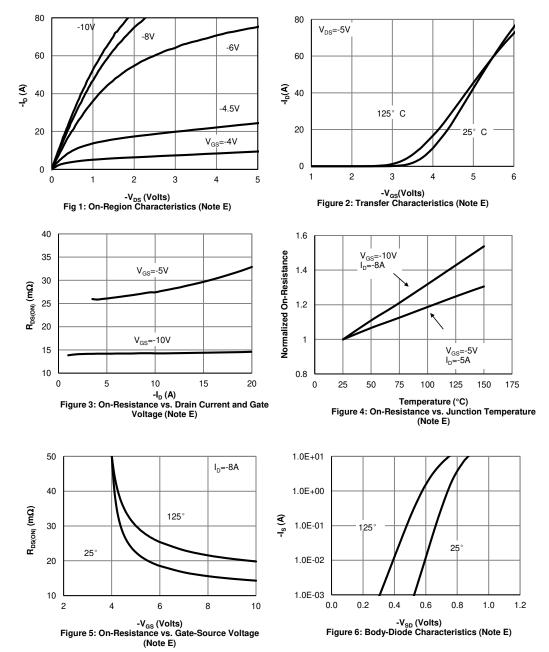
B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial $T_J = 25^{\circ}$ C.

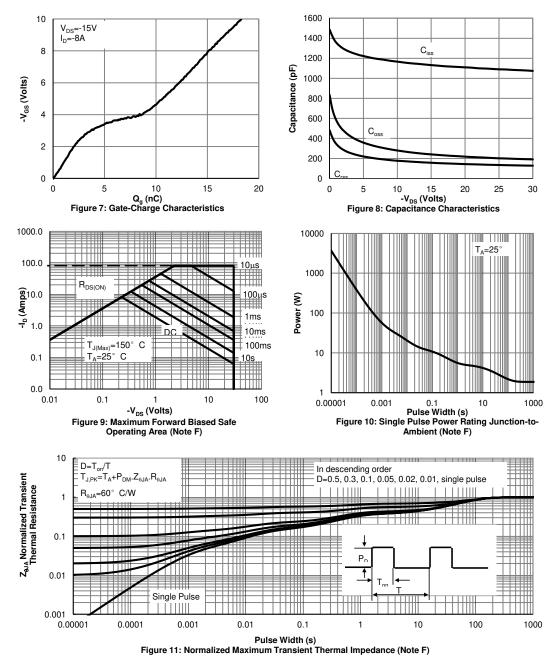
 D. The R_{0JA} is the sum of the thermal impedence from junction to case R_{0JC} and case to ambient.
E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited. H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C.

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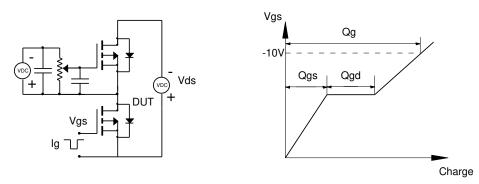


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

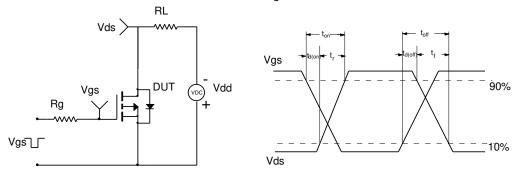


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

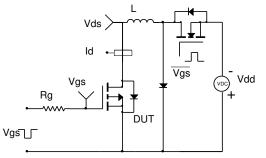
Gate Charge Test Circuit & Waveform

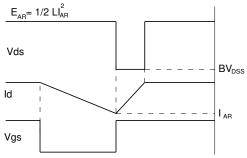


Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

